

## **Reliability Monitoring Results**

**Quarters:** Q1/2021 to Q4/2021 Based on structural similarity

SupplierUser Part NumberNexperia B.V.74VHCT595PW-Q100

Part Description: 8-bit serial-in/parallel-out shift register with output storage register; TTL enabled (3-state)

Function Family: VHC(T)
Process family: Super micron
Package family: TSSOP

| JESD47 | ' Test   | Test Conditions   | Duration                    | # Lots    | # Quantity | #<br>Rejects |
|--------|--|---|-----------------------------|-----------|------------|--------------|
| # 1    | <b>TEST</b> Pre- and Post-Stress Electrical Test                   | Tamb = 25 °C  | N/A                         | see below | all parts  | see<br>below |
| # 2    | PC<br>Preconditioning  | JESD22-A113<br>MSL 1  | N/A                         | 863       | 73980      | 0            |
| # 5a   | HTOL EFR High Temperature Operating Life Extrinsic                 | JESD22-A108<br>Tj = 150°C<br>$V_{CCMAX} \le V \le 1.2*V_{CCMAX}$  | 48 hours<br>or<br>168 hours | 128       | 38474      | 0            |
| # 5b   | <b>HTOL IFR</b> High Temperature Operating Life Intrinsic          | JESD22-A108<br>Tj = 150°C<br>$V_{CCMAX} \le V \le 1.2*V_{CCMAX}$  | ≥500 hours                  | 76        | 5079       | 0            |
| # 7    | TC Temperature Cycling   | JESD22-A104<br>-65 °C to 150°C                                    | ≥500 cycles                 | 478       | 37734      | 0            |
| # 9    | uHAST / HAST<br>unbiased or biased High<br>Accelerated Stress Test | JESD22-A101<br>Tamb = 130 °C,<br>RH = 85%, V = V <sub>CCMAX</sub> | 96 hours                    | 462       | 36246      | 0            |

## Calculation of PPM, FIT and MTTF

Test considered for PPM calculation: High Temperature Operating LifeTest Extrinsic (HTOL EFR, Test # 5a above) Test considered for FIT and MTTF calculations: High Temperature Operating LifeTest Intrinsic(HTOL IFR, Test # 5b above)

Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

| Product<br>Family | Package<br>Family | Quantity | Rejects | Extrinsic<br>Failure Rate (PPM) | Intrinsic<br>Failure Rate (FIT) | MTTF (hrs) |
|-------------------|-------------------|----------|---------|---------------------------------|---------------------------------|------------|
| VHC(T)            | TSSOP             | 5079     | 0       | 24                              | 0.7                             | 1.57 E+09  |